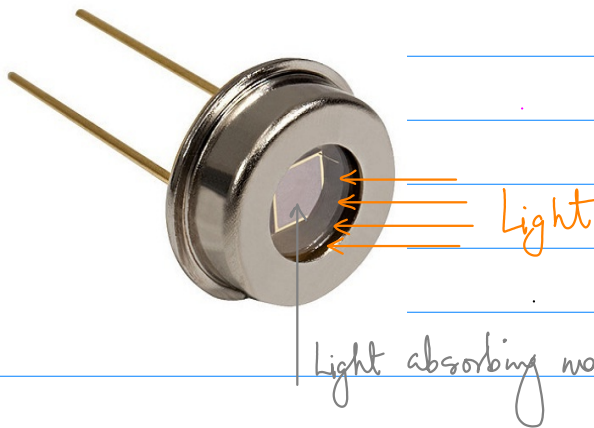


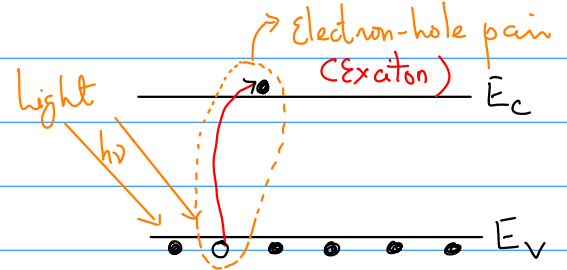
# Special Purpose Diodes

③

Photo-diode :

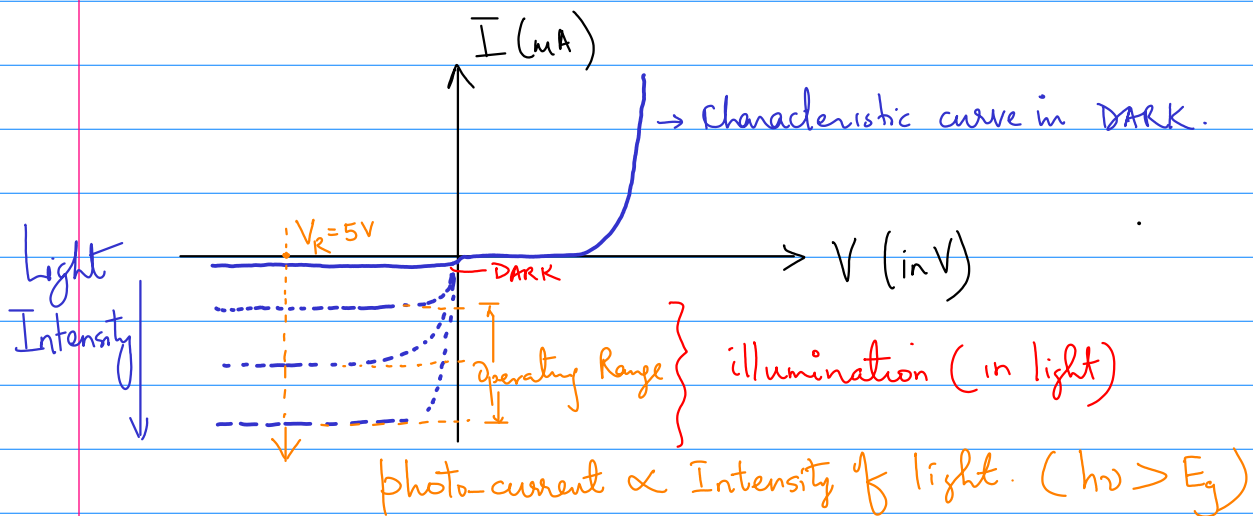


$T = 300K$   
 $\sim 25meV$

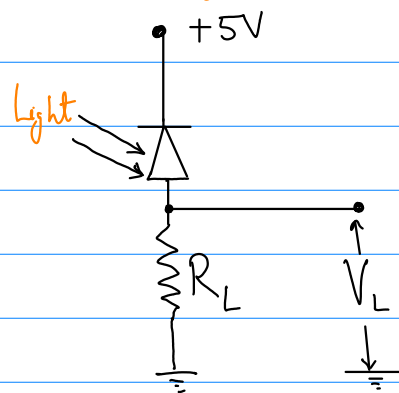


Light absorbing material : Generating electron-hole pairs

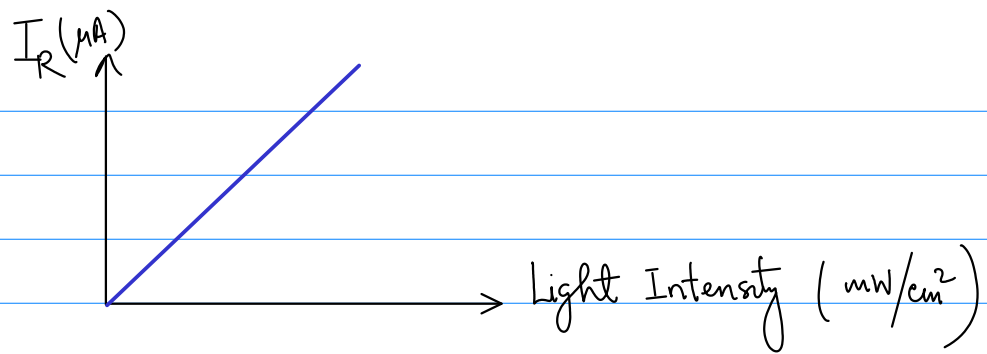
if the generated electron-hole pairs are dissociated, then "free" charge-carriers are released.  
 These charges constitute electric-current in external ckt.



Ckt. application:

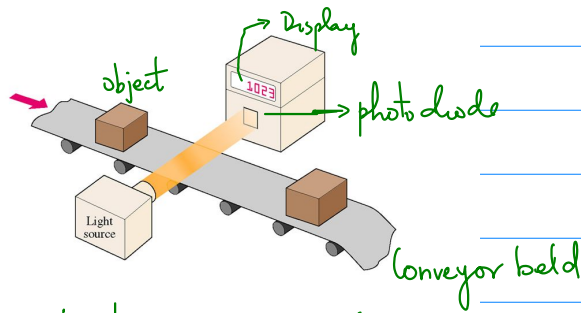


$V_L$  is directly proportional to the light intensity

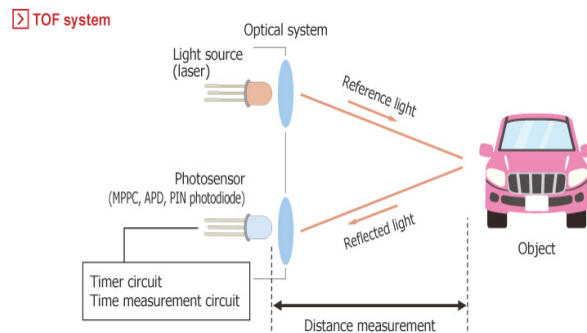


Application of photo-diodes:  
Electronic  
(i) Counter :

### The Photodiode Applications

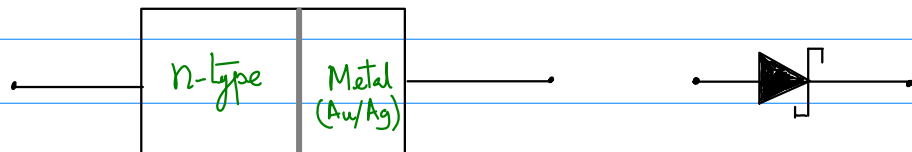


(ii) LiDAR (Light detection and Ranging) : Remote Sensing



④ The Schottky Diode (Hot carrier diode) :

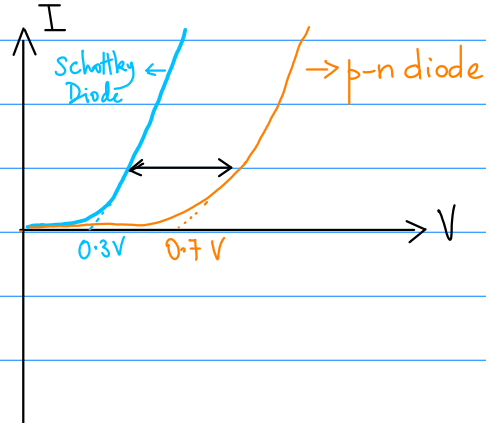
→ Metal-Semiconductor junction (No depletion layer)



- No p-n homojunction. Instead, it has metal-semiconductor junction.
- Operates only with majority charge-carriers (here, it is electron).  
→ Unipolar Device.

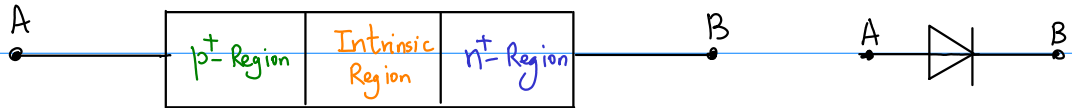
- It offer fast switching action.

### Current-Voltage Characteristics :



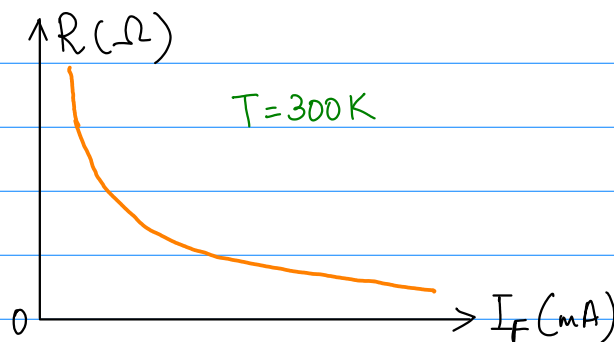
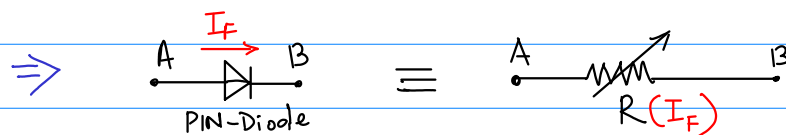
- Fast turn-ON.
- No minority current in reverse bias.

⑤. PIN Diode : Consists of heavily doped p- and n-regions separated by an intrinsic region.

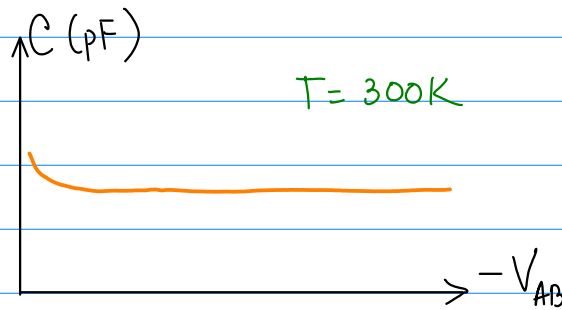
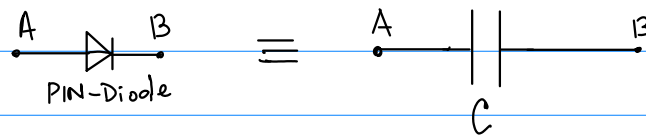


(i) In forward bias, i.e.,  $V_{AB} > 0$

- The charges from p- and n-regions get injected into the intrinsic region
- The resistance due to intrinsic region reduces.



(ii) Reverse-bias;  $V_{AB} < 0$ , the PIN diode is nearly a constant capacitor.



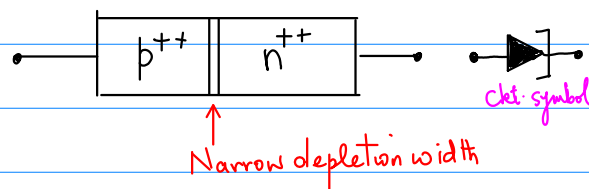
Applications of PIN-Diodes:

- (i) Since resistance is current controlled,  $R(I_F)$ ;
  - Modulating device (High frequency signal are modulated with low frequency bias variation).
  - As an attenuator device.

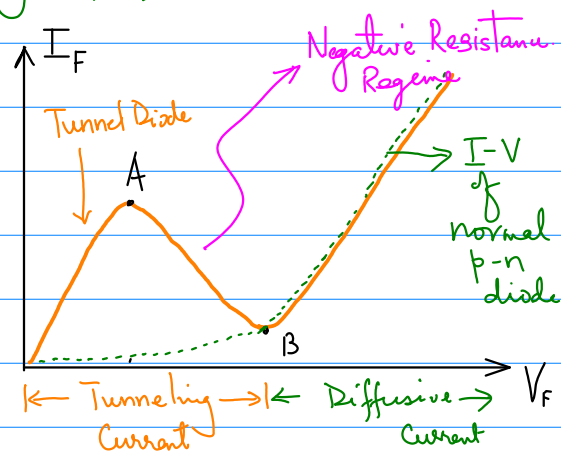
(ii) Certain p-i-n diodes are also used as photodetectors in fiber-optic system (communication).

(iii) Microwave switch ( $\sim$  GHz frequency range).

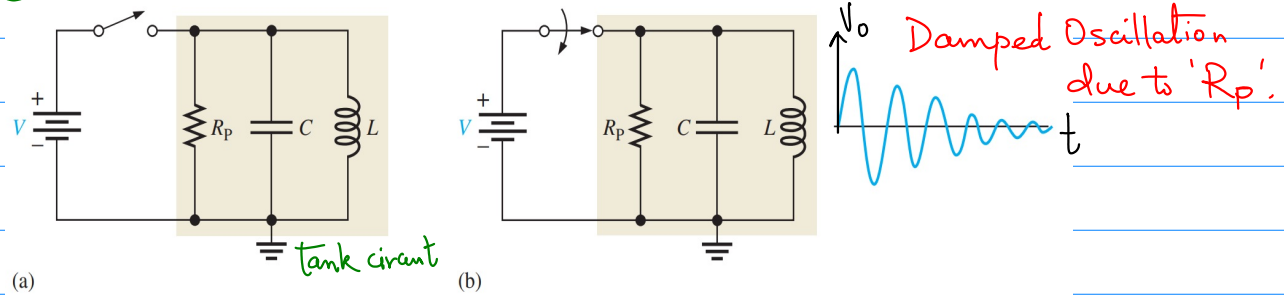
⑥ The Tunnel Diode: Ge/GaAs (heavily doped)



$$R_{AB} = \frac{\Delta V_{AB}}{\Delta I_{AB}} = -ve \text{ (opposite of Ohm's law)}$$



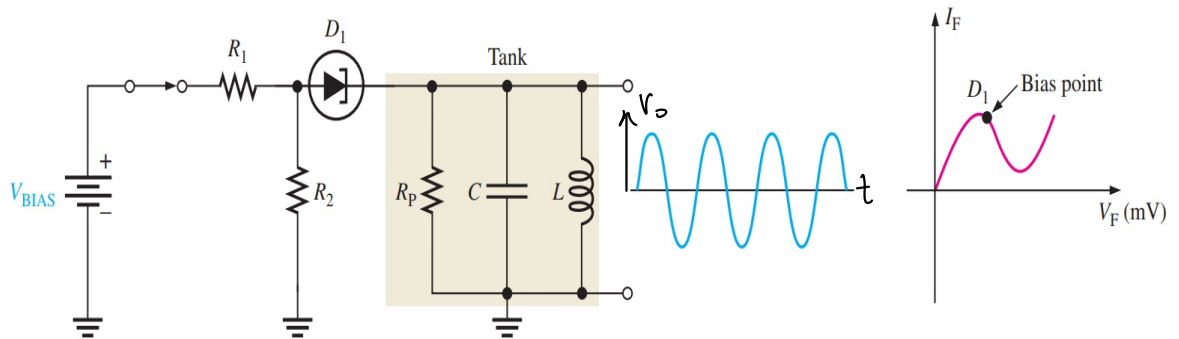
## Application of a Tunnel-diode : Oscillator Circuit :



▲ FIGURE 3-55

Parallel resonant circuit.

Tunnel-diode  $D_1$  is connected in series with the tank (oscillator).



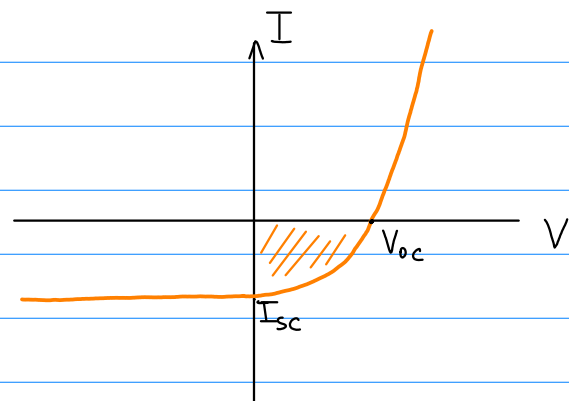
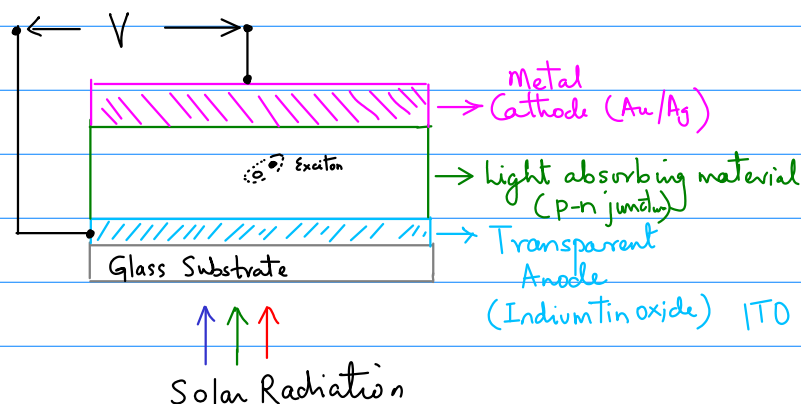
▲ FIGURE 3-56

Basic tunnel diode oscillator.

Negative resistance of the Tunnel-diode counters the positive resistance of the oscillator circuit.

⑦

## Solar Cells:



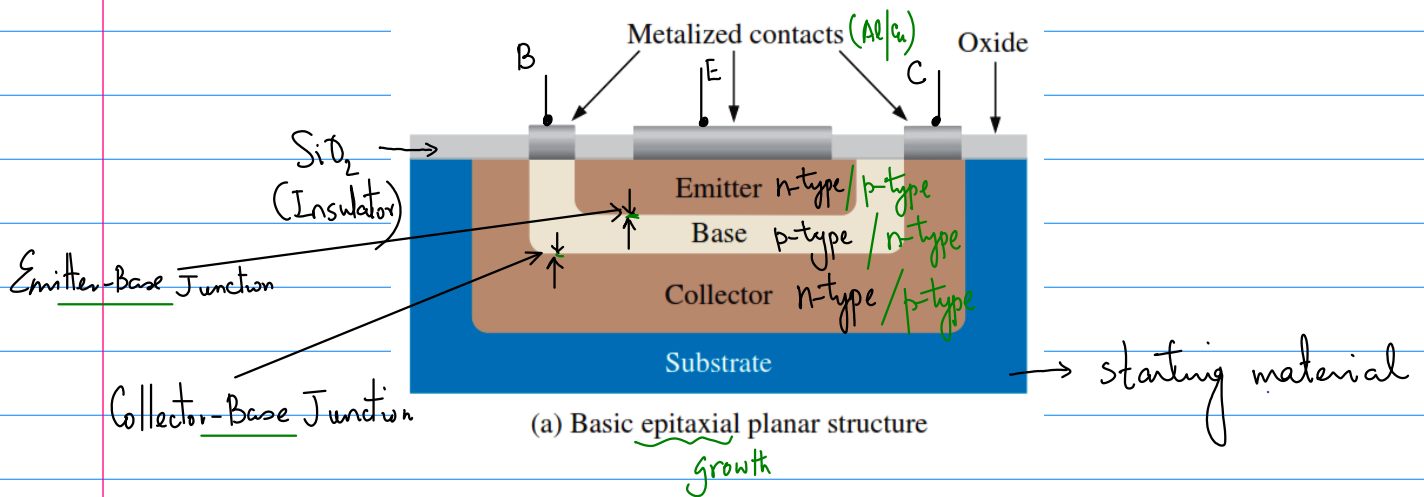
# Bipolar Junction Transistors (BJTs)

- 1951, William Shockley

Bipolar : Both electrons & holes are participating in device operation.

Junction : p-n / n-p (Barrier potential associated with junction).

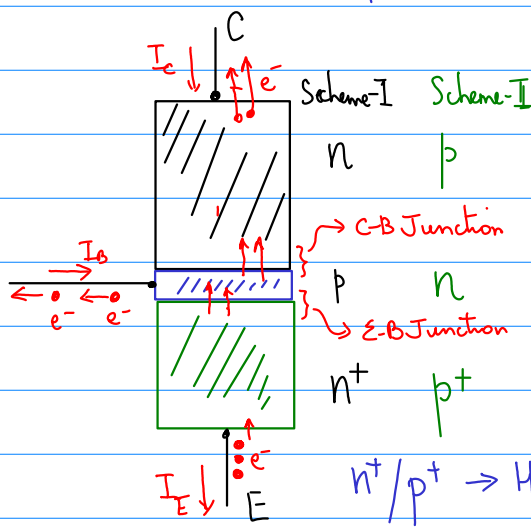
Transistor : Transfer of resistor (ie, transfer of current levels)



## Fabrication of a BJTs.

Thickness :

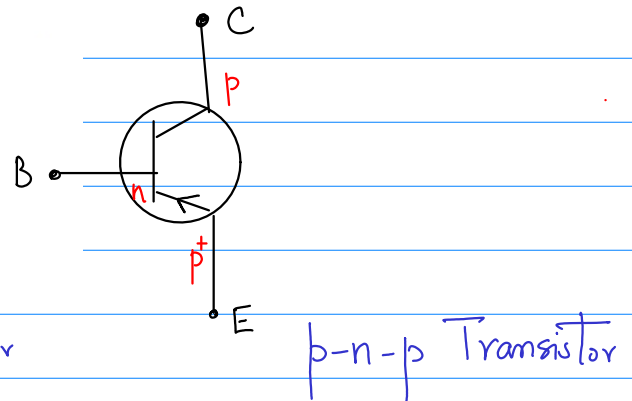
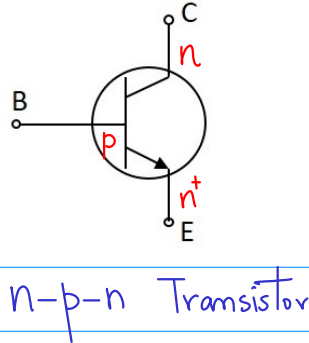
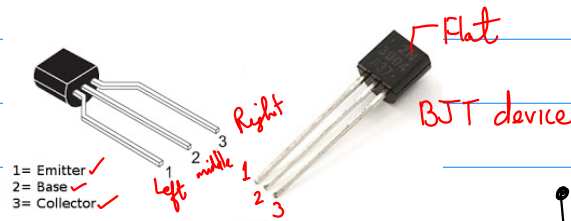
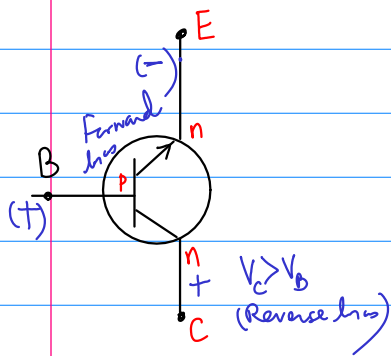
C : Thickest layer  
B : Thinnest layer  
E : Moderate thickness



Doping levels :

C : Moderately doped ( $\sim 10^{14-15} \text{ cm}^{-3}$ )  
B : Lightly doped ( $10^{12-13} \text{ cm}^{-3}$ )  
E : Heavily doped ( $10^{16-18} \text{ cm}^{-3}$ )

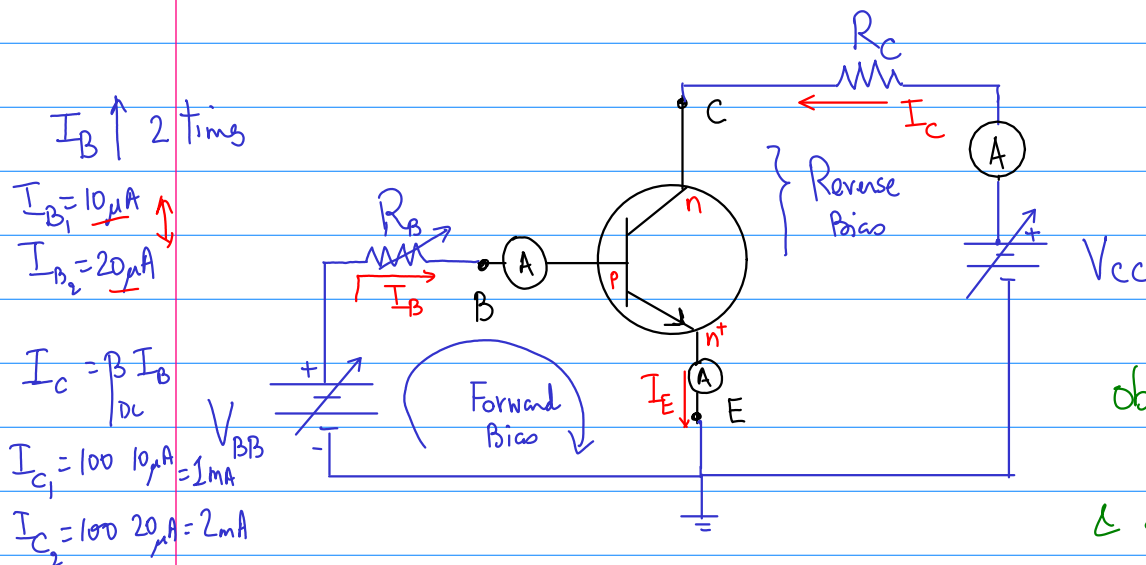
$n^+/p^+ \rightarrow$  Heavily doping



## Basic BJT operation :

(i) Emitter-Base Junction : Forward-Bias

(ii) Collector-Base Junction : Reverse-Bias



$$V_C > V_B$$

We are trying to observe the current levels in the collector, Base & Emitter terminal.

- Any change in the Base-Emitter terminals, the change is directly appearing in the collector terminal.

$$I_E = I_B + I_C$$

$$I_E ; I_C \sim \text{mA}$$

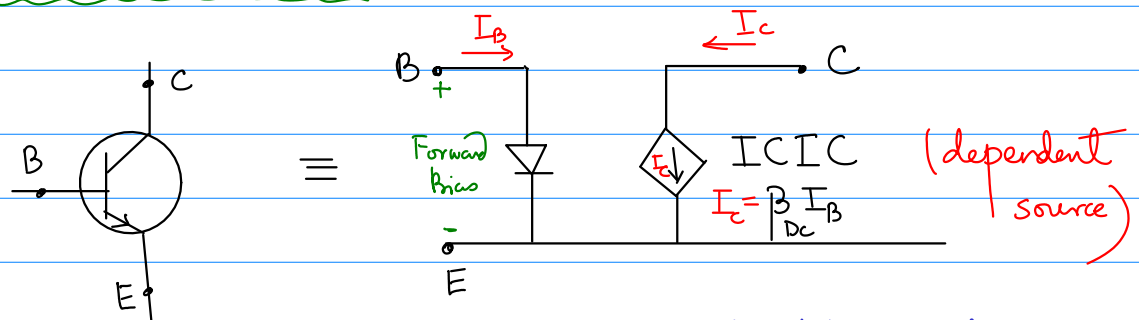
$$; I_B \sim \mu\text{A}$$

We define a parameter,  $\beta_{DC} = \frac{I_C}{I_B} = \frac{\sim \text{mA}}{\sim \mu\text{A}} \approx 100$  (typical)

$\beta_{DC}$  = typically varies b/w 50-300

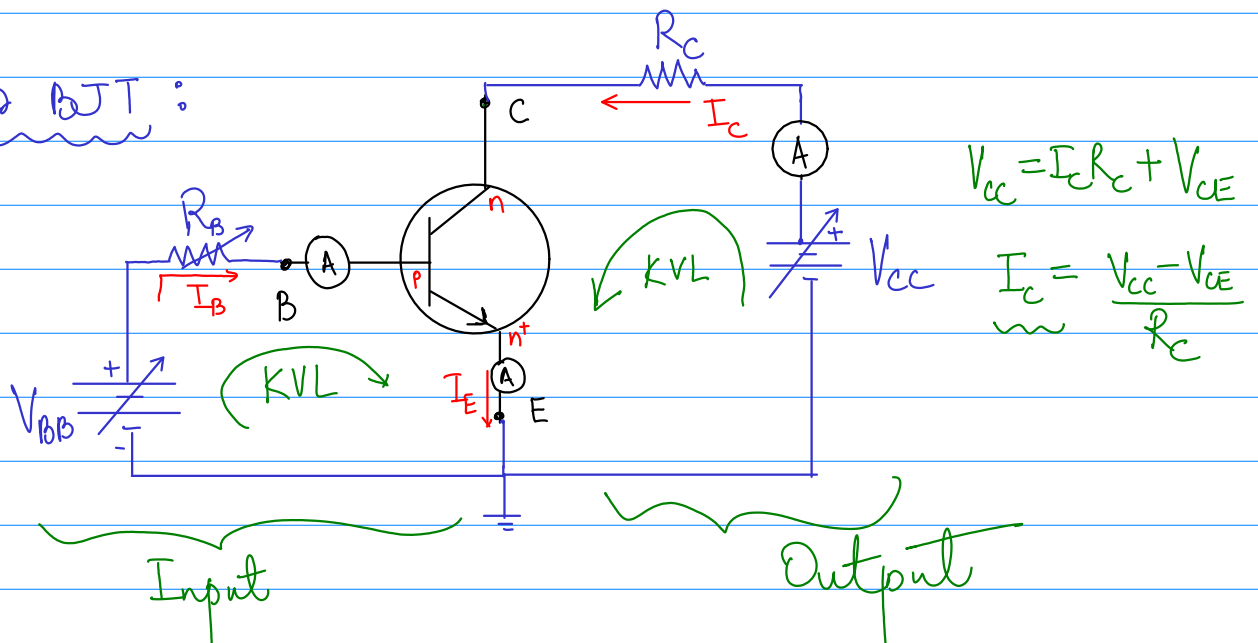
- Common-Emitter Current Gain ( $\beta_{DC}$ )
- Common-Base Current Gain ( $\alpha_{DC}$ )

Transistor DC Model:



Equivalent ckt model.

Biasing BJT:



$$V_{BB} = I_B R_B + V_{BE} \Rightarrow I_B = \frac{V_{BB} - V_{BE}}{R_B}$$